Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/550,888	FUKUSHIMA ET AL.
Examiner	Art Unit
Sophia S. Chen	2852

SEARCHED					
Class	Subclass	Date	Examiner		
399	159, 26, 162	4/11/2007	sc		
430	56, 902	4/11/2007	sc		
above	updated	7/5/2007	sc		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
Interfere	nce Sear Printont	7/5/2007	sc		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See search history printout	4/11/2007 Inplated or 7/5/07	sc (SC)		
EAST (EPO, JPO) - See search history printout	4/11/2007	sc		
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